## Applicant(s)/Patent Under Application/Control No. Reexamination 10/627,780 FAN, KEJUN Notice of References Cited Art Unit Examiner Page 1 of 1 1637 Young J. Kim **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name Country Code-Number-Kind Code MM-YYYY 435/270 US-6,342,387 01-2002 Hayashizaki et al. Α US-В US-С US-D US-Ε US-F US-G US-Н US-1 US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Classification Name Country Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U V W

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Х